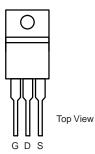


75N75-TA3-T-VB Datasheet N-Channel 80 V (D-S) MOSFET

| PRODUCT SUMMARY | | |
|-------------------------------|-----|-----|
| V _{DS} | 80 | V |
| $R_{DS(on)}$ $V_{GS} = 10$ V | 7 | mΩ |
| $R_{DS(on)}$ $V_{GS} = 4.5$ V | 9 | mΩ |
| I _D | 100 | А |
| Configuration | Sin | gle |



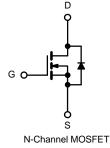


FEATURES

- Trench Power MOSFET
- + 100 $\%~\text{R}_{g}$ and UIS Tested

APPLICATIONS

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



| ABSOLUTE MAXIMUM RATINGS (| T _A = 25 °C, unless | s otherwise no | oted) | | |
|--|--------------------------------|-----------------------------------|----------------------|----|--|
| Parameter | Symbol | Limit | Unit | | |
| Drain-Source Voltage | | V _{DS} | 80 | V | |
| Gate-Source Voltage | | V _{GS} | ± 20 | v | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 25 °C | | 100ª | | |
| | T _C = 70 °C | | 85 ^a | | |
| | T _A = 25 °C | I _D | 28.6 ^{b, c} | А | |
| | T _A = 70 °C | | 24.9 ^{b, c} | | |
| Pulsed Drain Current (t = 100 µs) | | I _{DM} | 350 | | |
| | T _C = 25 °C | I _S | 80 ^a | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | | 4.5 ^{b, c} | | |
| Single Pulse Avalanche Current | ent L = 0.1 mH | | 30 | | |
| Single Pulse Avalanche Energy | L = 0.1 MH | E _{AS} | 45 | mJ | |
| | T _C = 25 °C | | 180 | W | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 120 | | |
| | T _A = 25 °C | | 5 ^{b, c} | | |
| | T _A = 70 °C | | 3.2 ^{b, c} | | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 150 | ാം | |
| Soldering Recommendations (Peak Temperature) | | | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|--|------------------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| | $t \le 10 \text{ sec}$ | R _{thJA} | 15 | 18 | | |
| Maximum Junction-to-Ambient ^a | Steady State | | 40 | 50 | °C/W | |
| Maximum Junction-to-Case | | R _{thJC} | 0.85 | 1.1 | | |

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|-------------------------|--|------|-------|-------|-------|
| Static | | | | 1 | 1 | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_{D} = 250 \mu A$ | 80 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | | | 37 | | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 6.1 | | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th}) | V _{DS} = V _{GS} , I _D = 250 μA | 2.0 | | 3.5 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA |
| | | $V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | |
| Zero Gate Voltage Drain Current | IDSS | $V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | | | 10 | μA |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ | 85 | | | А |
| | - () | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$ | | 7 | | 1 |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 6 V, I _D = 15 A | | 7.5 | | mΩ |
| | | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 10 \text{ A}$ | | 9 | | |
| Forward Transconductance ^a | 9 _{fs} | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$ | | 60 | | S |
| Dynamic ^b | | | | | • | |
| Input Capacitance | C _{iss} | | | 3855 | | |
| Output Capacitance | C _{oss} | V_{DS} = 40 V, V_{GS} = 0 V, f = 1 MHz | | 1120 | | pF |
| Reverse Transfer Capacitance | C _{rss} | | | 376 | | |
| | | $V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ | | 35.5 | | |
| Total Gate Charge | Qg | $V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$ | | 22 | | |
| | | | | 18 | | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$ | | 5.3 | | - nC |
| Gate-Drain Charge | Q _{gd} | | | 7.3 | | |
| Output Charge | Q _{oss} | $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$ | | 57 | 86 | |
| Gate Resistance | R _g | f = 1 MHz | 0.5 | 1.3 | 2 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 12 | 24 | |
| Rise Time | t _r | V_{DD} = 40 V, R_L = 4 Ω | | 8 | 16 | |
| Turn-Off DelayTime | t _{d(off)} | $\text{I}_\text{D}\cong~$ 10 A, V_GEN = 10 V, R_g = 1 Ω | | 32 | 64 | |
| Fall Time | t _f | | | 7 | 14 | |
| Turn-On Delay Time | t _{d(on)} | | | 14 | 28 | ns |
| Rise Time | t _r | $V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$ | | 11 | 22 | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong 10 \text{ A}, V_{GEN} = 6.0 \text{ V}, R_g = 1 \Omega$ | | 30 | 60 |] |
| Fall Time | t _f | | | 8 | 16 | |
| Drain-Source Body Diode Characteristic | s | | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 75 | А |
| Pulse Diode Forward Current (t = 100 μ s) | I _{SM} | | | | 150 | |
| Body Diode Voltage | V _{SD} | I _S = 5 A | | 0.76 | 1.1 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 38 | 75 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | L = 10 A dl/dt = 100 A/wa T = 05 °C | | 36 | 70 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$ | | 19 | | 200 |
| Reverse Recovery Rise Time | t _b | | | 19 | | ns |

Notes

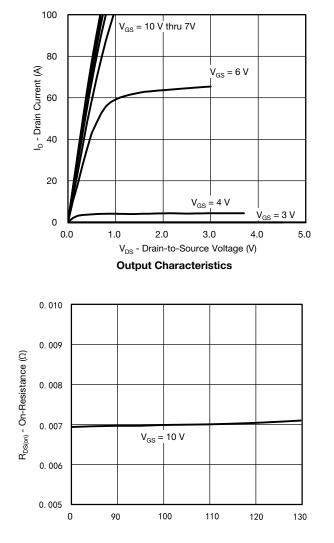
a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

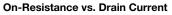
b. Guaranteed by design, not subject to production testing.

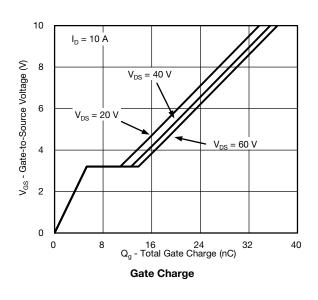
VBsemi /Bsemi.com

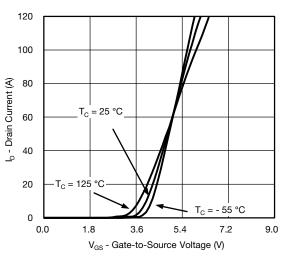
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



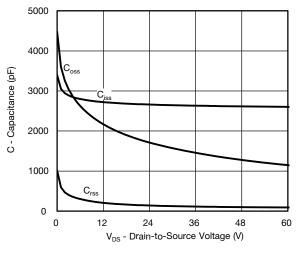




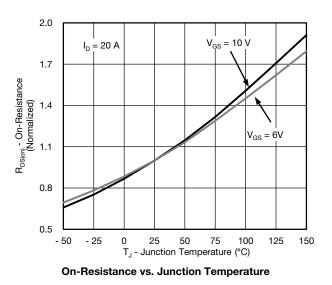




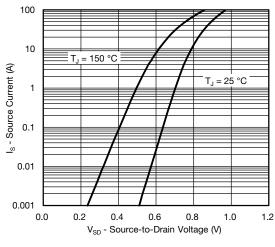
Transfer Characteristics



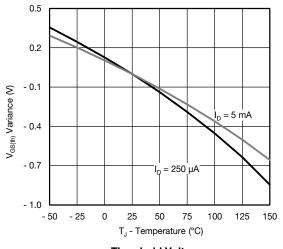




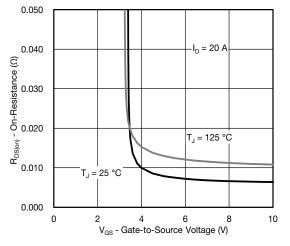




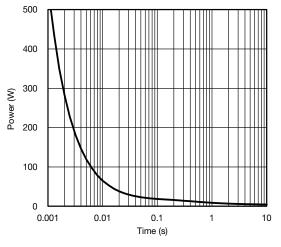
Source-Drain Diode Forward Voltage



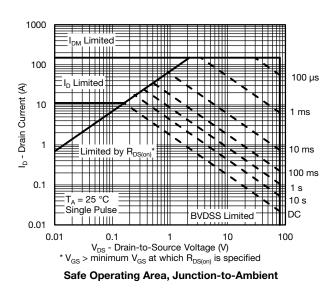




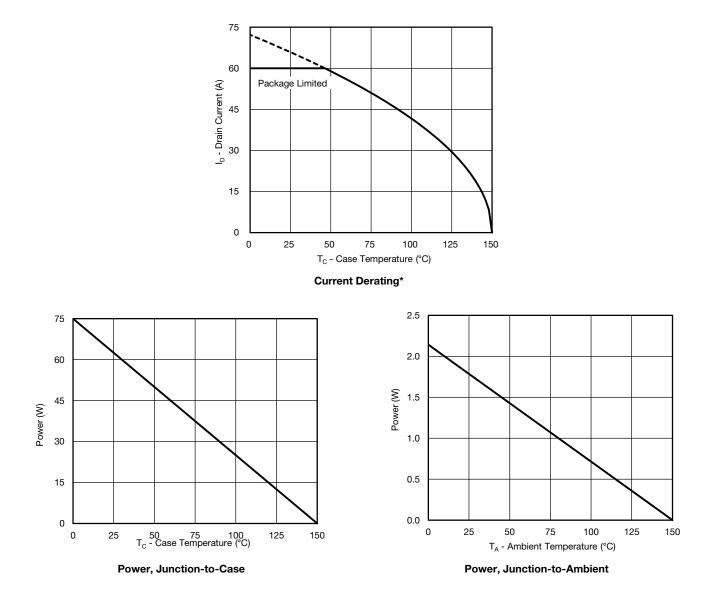
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

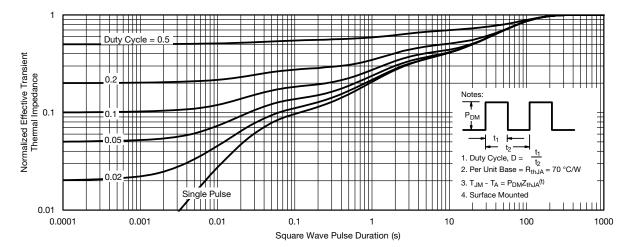




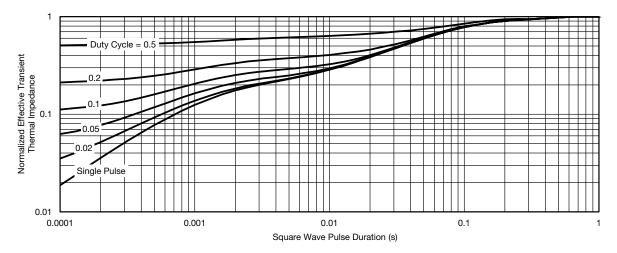


* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





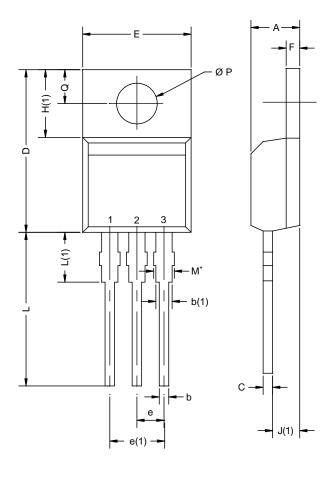
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



| | MILLIN | IETERS | INCHES | | |
|-----------------------|-------------------|-----------|--------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| Е | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: X12- DWG: 547 | 0208-Rev. N, 1 | 08-Oct-12 | | | |

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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